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Attorney's Docket No.: 07977-226002 / US3548D1



## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant: Hisashi Ohtani Art Unit: 1765

Serial No.: 09/596,755 Examiner: Robert Kunemund

Filed : June 15, 2000

Title : MANUFACTURING METHOD OF SEMICONDUCTOR AND

MANUFACTURING METHOD OF SEMICONDUCTOR DEVICE

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

## REQUEST FOR INITIALED PTO FORM 1449 & 892

Upon reviewing the file, applicants noted that they have not received an initialed copy of the PTO Form 1449 and 892 that accompanied an information disclosure statement filed February 10, 1998.

Applicants' records show that this information disclosure statement complied with 37 CFR 1.97. For the Examiner's convenience, all of the references identified on the two PTO-892 forms and the two PTO-1449 forms have been combined in one document (identified as Appendix A). Thus, it is respectfully requested that the examiner initial and return the forms as originally submitted or, in the alternative, initial and return the revised PTO-1449 as soon as possible.

The examiner's prompt attention to this matter would be greatly appreciated.

Respectfully submitted,

Date: Uctober 28, 2003

William G. Hughes,

Reg. No. 46,112

Fish & Richardson P.C. 1425 K Street, N.W. 11th Floor Washington, DC 20005-3500 (202) 783-5070 telephone (202) 783-2331 facsimile WXH/adt 40184277.doc

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Application No.

09/021,639

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Applicant Hisashi Ohtani

Filing Date

February 10, 1998

Group Art Unit 2822

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Application No. 09/021,639

Applicant(s)

Examiner

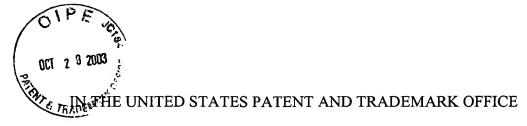
Hisashi Ohtani Group Art Unit

James Park

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## APPENDIX A (FORM PTO-1449)

Customer No. 26171

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Substitute (Modified)	Form P 10 1449

U.S. Department of Commerce Patent and Trademark Office

Attorney's Docket No. 07977-226002

Application No. 09/596,755

**Information Disclosure Statement by Applicant** (Use several sheets if necessary)

Applicant Hisashi Ohtani

Group Art Unit

(37 CFR §1.98(b))

Filing Date June 15, 2000 1765

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Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
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Initial	ID	Number	Date	Patent Office	Class	Subclass	Yes	No	
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